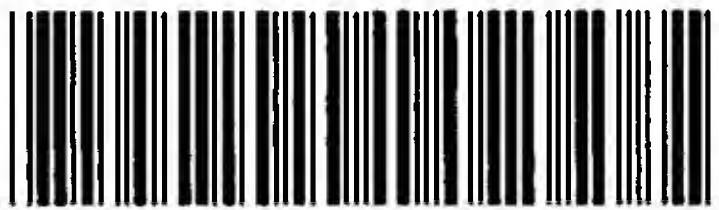


<div>Search Notes</div> <div></div>	Application/Control No. 10556233	Applicant(s)/Patent Under Reexamination BIEHL ET AL.
	Examiner Cho, Jennifer Y	Art Unit 1621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search	7/9/07	JD
East Search	7/13/07	JC
Inventor Search	7/17/07	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner